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APPLICATION NO.	Fil	LING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/064,812	2 08/20/2002		Dong-Bo Hao		7772
23900	7590	06/20/2005	•	EXAM	INER
J C PATEN 4 VENTURI	•		BONURA, TIMOTHY M		
IRVINE, C	•	.50		ART UNIT	PAPER NUMBER
-				2114	

DATE MAILED: 06/20/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

1							
	Application No.	Applicant(s)					
	10/064,812	HAO ET AL.					
Office Action Summary	Examiner	Art Unit					
	Tim Bonura	2114					
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION  - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a re  - If NO period for reply is specified above, the maximum statutory perior  - Failure to reply within the set or extended period for reply will, by statu. Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).		oly be timely filed  (30) days will be considered timely.  HS from the mailing date of this communication.  NDONED (35 U.S.C. § 133).					
Status							
1) Responsive to communication(s) filed on 20	Responsive to communication(s) filed on 20 August 2002.						
3) Since this application is in condition for allow	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the practice under	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims							
4)⊠ Claim(s) <u>1-20</u> is/are pending in the application.							
4a) Of the above claim(s) is/are withdr	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.	,						
6)⊠ Claim(s) <u>1-20</u> is/are rejected.							
7) Claim(s) is/are objected to.	· · · ——						
8) Claim(s) are subject to restriction and	Claim(s) are subject to restriction and/or election requirement.						
Application Papers							
9) The specification is objected to by the Examiner.							
10)⊠ The drawing(s) filed on <u>20 August 2002</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.							
Priority under 35 U.S.C. § 119							
12)⊠ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).							
a)⊠ All b)□ Some * c)□ None of:							
1.☐ Certified copies of the priority documents have been received.							
2. Certified copies of the priority documents have been received in Application No							
3. Copies of the certified copies of the priority documents have been received in this National Stage							
application from the International Bureau (PCT Rule 17.2(a)).							
* See the attached detailed Office action for a list of the certified copies not received.							
Attachment(s)							
1) X Notice of References Cited (PTO-892)		mmary (PTO-413)					
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)		/Mail Date ormal Patent Application (PTO-152)					
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0	8) 5) Notice of inf	ormai catent Application (CTO-132)					

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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claim1- are rejected under 35 U.S.C. 103(a) as being unpatentable over Harrington, et al, U.S. Patent Number 6,775,192 and further in view of Miner, U.S. Patent Number 6,862,704.
- 3. Regarding claim 1:
  - a. Regarding the limitation of "a command translation unit, coupled to the computer main board through a standard interface for receiving and translation a write-in data from a specified port address and latching up the translated write-in data," Harrington discloses a system with a DRDRAM which is connected to a memory device to check power operational states of specific address in memory. (Lines 57-65 of Column 2). Harrington also discloses that any connector capable of receiving a signal for test can be used to connect the tester to the memory. (Lines 40-48 of Column 5, see also Figure 2).
  - b. Regarding the limitation of "a test procedure control unit, coupled to the command translation unit and the computer main board for issuing test control commands according to a preset testing procedure and reading the latched write-in data inside the command translation unit so that functionality of the computer main board is assessed and results are registered," Harrington discloses a system in which DRDRAM issues test commands based on stored readable instructions (Lines 25-30 of Column 6). Harrington

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also discloses that test results are gathered and analyzed by the DRDRAM during testing. (Lines 38-60 of Column 7 and Lines 55-60 of Column 8). Harrington does not disclose a test procedure control unit that can latch write-in data inside the computer main board. Miners discloses a system with a test management logic that accepts test parameter in a configuration register and are transferred from the test controller over the test control bus. (Lines 18-20 of Column 11). It would have been obvious to one of ordinary skill in the art at the time of the invention to combine the power test circuitry of Harrington with the BIST of Miner. One of ordinary skill would have been inclined because Harrington discloses the need of and external memory testing device for storing testing procedures. (Lines 5-18 of Column 6). Miner discloses this test management logic external to the system to fulfill the stated need of Harrington. (See Miner figure 5).

- 4. Regarding claim 2, Miner discloses a system with means to display and analysis results from test commands. (Lines 53-60 of Column 11).
- 5. Regarding claim 3, Harrington discloses a system wherein test instructions can be stored and selected from 3 CAL commands. (Lines 58-60 of Column 6).
- 6. Regarding claim 4, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7).
- 7. Regarding claim 5, Miner discloses a system with means to display test commands configurations for an operator to configure. (Lines 30-34 of Column 12).
- 8. Regarding claim 6, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7). Harrington discloses that the system can enter a standby state via a command. (Lines 45-47 of Column 6).

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9. Regarding claim 7, Miner discloses a system in which the number of repetitions of a test procedure is programmable. (Lines 35-45 of Column 10).

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- 10. Regarding claim 8, Harrington discloses a system wherein the testing instructions can be stored in ROM. (Lines 30-32 of Column 6).
- 11. Regarding claim 9:
  - Regarding the limitation of "a computer main board testing device connected to a C. standard interface on the computer main board, wherein the testing device controls the switching and resetting of the computer main board so that test control commands are sequentially transmitted according to preset testing procedures," Miners discloses a system with a test management logic that accepts test parameter in a configuration register and are transferred from the test controller over the test control bus. (Lines 18-20 of Column 11). Miner does not disclose a system with a power test procedure. Harrington discloses a system with a DRDRAM, which is connected to a memory device to check power operational states of specific address in memory. (Lines 57-65 of Column 2). It would have been obvious to one of ordinary skill in the art at the time of the invention to combine the power test circuitry of Harrington with the BIST of Miner. One of ordinary skill would have been inclined because Harrington discloses the need of and external memory testing device for storing testing procedures. (Lines 5-18 of Column 6). Miner discloses this test management logic external to the system to fulfill the stated need of Harrington. (See Miner figure 5).
  - d. Regarding the limitation of "a computer main board," Miner discloses a microprocessor. (Lines 55-57 of Column 11, see Figure 5).

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12. Regarding claim 10, Miner discloses a system with means to display and analysis results from test commands. (Lines 53-60 of Column 11).

- 13. Regarding claim 11, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7).
- 14. Regarding claim 12, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7). Harrington discloses that the system can enter a standby state via a command. (Lines 45-47 of Column 6).
- 15. Regarding claim 13, Harrington also discloses that any connector capable of receiving a signal for test can be used to connect the tester to the memory. (Lines 40-48 of Column 5, see also Figure 2). Harrington also discloses that test results are gathered and analyzed by the DRDRAM during testing. (Lines 38-60 of Column 7 and Lines 55-60 of Column 8).
- 16. Regarding claim 14, Miner discloses a system that can find errors on a bit-by-bit basis and store those errors. (Lines 48-67 of Column 11).

## 17. Regarding claim 15:

- e. Regarding the limitation of "sequentially issuing test control commands according to a preset testing procedure for controlling the switching and resetting of the computer main board," Harrington discloses a system in which DRDRAM issues test commands based on stored readable instructions (Lines 25-30 of Column 6). Harrington also discloses that test results are gathered and analyzed by the DRDRAM during testing.

  (Lines 38-60 of Column 7 and Lines 55-60 of Column 8).
- f. Regarding the limitation of "retrieving write-in data from a specified port address; translating write-in data through a standard interface on the computer main board so that

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functionality of the computer main board is assessed and test results are registered," Harrington discloses a system with a DRDRAM which is connected to a memory device to check power operational states of specific address in memory. (Lines 57-65 of Column 2). Harrington also discloses that any connector capable of receiving a signal for test can be used to connect the tester to the memory. (Lines 40-48 of Column 5, see also Figure 2). Harrington does not disclose a test procedure control unit that can latch writein data inside the computer main board. Miners discloses a system with a test management logic that accepts test parameter in a configuration register and are transferred from the test controller over the test control bus. (Lines 18-20 of Column 11). It would have been obvious to one of ordinary skill in the art at the time of the invention to combine the power test circuitry of Harrington with the BIST of Miner. One of ordinary skill would have been inclined because Harrington discloses the need of and external memory testing device for storing testing procedures. (Lines 5-18 of Column 6). Miner discloses this test management logic external to the system to fulfill the stated need of Harrington. (See Miner figure 5).

- 18. Regarding claim 16, Miner discloses a system with means to display and analysis results from test commands. (Lines 53-60 of Column 11).
- 19. Regarding claim 17, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7).
- 20. Regarding claim 18, Harrington discloses a system wherein a Standby/reduced power state is tested. (Lines 4-6 of Column 3 and Lines 57-60 of Column 7). Harrington discloses that the system can enter a standby state via a command. (Lines 45-47 of Column 6).

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21. Regarding claim 19, Miner discloses a system in which the number of repetitions of a test

procedure is programmable. (Lines 35-45 of Column 10).

22. Regarding claim 20, Harrington also discloses that any connector capable of receiving a

signal for test can be used to connect the tester to the memory. (Lines 40-48 of Column 5, see

also Figure 2).

Claim Objections

23. Claims 1, 9 and 15 objected to because of the following informalities: In claims 1 and

15, there are multiple occurrences of the word "and" and a subsequent word lacking a space in

between the words. In claim 1, 4th line of the claim, "anda" should be "and a". In claim 9, 2nd

line of the claim, "anda" should be "and a". In claim 15, 4th line of the claim, "andretrieving"

and "andtranslation" both have the same mistakes. Appropriate correction is required.

Conclusion

24. Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Tim Bonura.

The examiner can normally be reached on Mon-Fri: 8:30-5:00.

The examiner can be reached at: 571-272-3654.

25. If attempts to reach the examiner by telephone are unsuccessful, please contact the

examiner's supervisor, Rob Beausoliel.

o The supervisor can be reached on 571-272-3645.

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26. The fax phone numbers for the organization where this application or proceeding is

assigned are:

o 703-872-9306 for all patent related correspondence by FAX.

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Information regarding the status of an application may be obtained from the Patent 27.

Application Information Retrieval (PAIR) system. Status information for published applications

may be obtained from either Private PAIR or Public PAIR. Status information for unpublished

applications is available through Private PAIR only. For more information about the PAIR

system, see http://pair-direct.uspto.gov/. Should you have questions on access to the Private

PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

28. Any inquiry of a general nature or relating to the status of this application or proceeding

should be directed to the receptionist whose telephone number is: 571-272-2100.

**29**. Responses should be mailed to:

**Commissioner of Patents and Trademarks** 

P.O. Box 1450

Alexandria, VA 22313-1450

PRIMARY EXAMINER

tmb

June 13, 2005

Tim Bonura Examiner Art Unit 2114